

**Search Notes**

Application/Control No.

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KEVIN MEW

Applicant(s)/Patent under  
Reexamination

ACHARYA ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
370/230, 230.1, 231, 232, 233, 234 370/235, 352, 412, 428, 429 (Text search only - see search history printout)	2/25/2008	KM